

Notice of References Cited	Application/Control No. 10/760,307		Applicant(s)/Patent Under Reexamination HWANN, SUNG-HEE	
	Examiner MUHAMMAD N. EDUN		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,269,058	07-2001	Yamanoi et al.	369/47.28
*	B	US-5,526,332	06-1996	Yamada et al.	369/47.35
	C	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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